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RF POWER MOSFET

N-CHANNEL ENHANCEMENT MODE



ARF1505



300V 750W

40MHz

The ARF1505 is an RF power transistor designed for off-line 300V operation in very high power scientific, commercial, medical and industrial RF power generator and amplifier applications up to 40 MHz.

- Specified 300 Volt, 27.12 MHz Characteristics:
 - Output Power = 750 Watts.
 - Gain = 17dB (Class C)
 - Efficiency > 75%

- High Performance Power RF Package.
- Very High Breakdown for Improved Ruggedness.
- Low Thermal Resistance.
- Nitride Passivated Die for Improved Reliability.

MAXIMUM RATINGS

All Ratings: $T_C = 25^{\circ}$ C unless otherwise specified.

Symbol	Parameter	ARF1505	UNIT
V _{DSS}	Drain-Source Voltage	1200	Volts
I _D	Continuous Drain Current @ T _C = 25°C	25	Amps
V _{GS}	Gate-Source Voltage	±30	Volts
P _D	Total Device Dissipation @ T _C = 25°C	1500	Watts
T _J ,T _{STG}	Operating and Storage Junction Temperature Range	-55 to 200	
T _L	Lead Temperature: 0.063" from Case for 10 Sec.	300	°C

STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
BV _{DSS}	Drain-Source Breakdown Voltage (V _{GS} = 0V, I _D = 250 μA)	1200			\/-It-
V _{DS(ON)}	On State Drain Voltage (I _{D(ON)} = 12.5A, V _{GS} = 10V)		8	9.5	Volts
I _{DSS}	Zero Gate Voltage Drain Current (V _{DS} = V _{DSS} , V _{GS} = 0V)		100		
	Zero Gate Voltage Drain Current (V _{DS} = 0.8 V _{DSS} , V _{GS} = 0V, T _C = 125°C)			1000	μA
I _{GSS}	Gate-Source Leakage Current (V _{GS} = ±30V, V _{DS} = 0V)	- (8)		±400	nA
g _{fs}	Forward Transconductance (V _{DS} = 25V, I _D = 12.5A)	5.5	6		mhos
Visolation	RMS Voltage (60Hz Sinewave from terminals to mounting surface for 1 minute)				Volts
V _{GS(TH)}	Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = 50mA)	3		5	Volts

WW.DZSC. THERMAL CHARACTERISTICS

Symbol	Characteristic (per package unless otherwise noted)		TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case			0.12	°C/M
R_{\thetaCS}	Case to Sink (Use High Efficiency Thermal Joint Compound and Planar Heat Sink Surface.)		0.09		°C/W

CAUTION: These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
C _{iss}	Input Capacitance	V _{GS} =0V		5400	6500	
C _{oss}	Output Capacitance	V _{DS} = 200V		300	400	pF
C _{rss}	Reverse Transfer Capacitance	f = 1 MHz		125	160	
t _{d(on)}	Turn-on Delay Time	V _{GS} = 15V		8		
t _r	Rise Time	$V_{DD} = 0.5 V_{DSS}$		5		ns
t _{d(off)}	Turn-off Delay Time	$I_D = I_{D[Cont.]} @ 25^{\circ}C$		25		113
t _f	Fall Time	$R_G = 1.6 \Omega$		13		

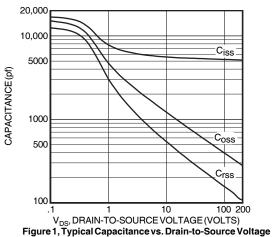
FUNCTIONAL CHARACTERISTICS

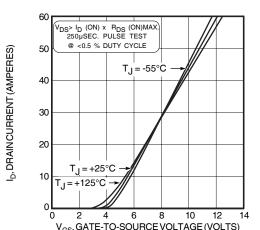
Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT		
G _{PS}	Common Source Amplifier Power Gain	f = 27.12 MHz	15	17		dB		
η	Drain Efficiency	$V_{GS} = 0V$ $V_{DD} = 300V$	70	75		%		
Ψ	Electrical Ruggedness VSWR 10:1	P _{out} = 750W	No Degi	radation	on in Output Power			

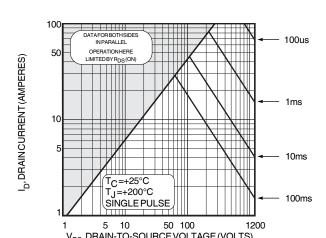
① Pulse Test: Pulse width < 380 μ S, Duty Cycle < 2%.

APT Reserves the right to change, without notice, the specifications and information contained herein.

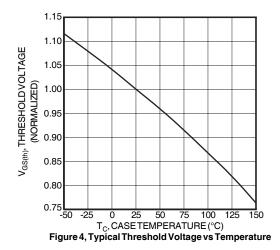
Per transistor section unless otherwise specified.

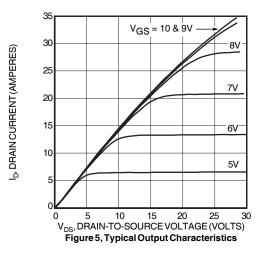


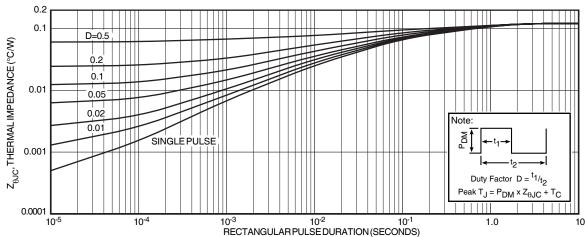




ARF1505







TYPICAL LARGE SIGNAL INPUT - OUPUT IMPEDANCE CHARACTERISTICS

F (MHz)	Z _{in} (Ω)	$Z_{OL}\left(\Omega\right)$
2.0	5.4 - j 9.6	46 - j 10.5
13.5	0.30 - j 1.2	16.4 - j 23
27	0.26 + j .58	4.9 - j 14.6
40	0.36 + j 1.6	2.3 - j 10.3
70	0.00 + 1 1.0	2.0) 10.0

Figure 6, Maximum Effective Transient Thermal Impedance, Junction-to-Case vs. Pulse Duration

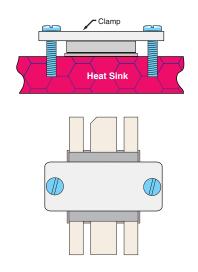
 Z_{in} - Gate shunted with 25Ω Z_{OL} - Conjugate of optimum load for 750 Watts output I_{DQ} = 100mA V_{dd} = 300V

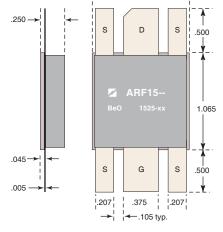
1.065

Thermal Considerations and Package Mounting:

The rated 1500W power dissipation is only available when the package mounting surface is at 25°C and the junction temperature is 200°C. The thermal resistance between junctions and case mounting surface is 0.12 °C/W. When installed, an additional thermal impedance of 0.1°C/W between the package base and the mounting surface is typical. Insure that the mounting surface is smooth and flat. Thermal joint compound must be used to reduce the effects of small surface irregularities. The heatsink should incorporate a copper heat spreader to obtain best results.

The package is designed to be clamped to a heatsink. A clamped joint maintains the required mounting pressure while allowing for thermal expansion of both the device and the heat sink. A simple clamp, and two 6-32 (M3.5) screws can provide the minimum 125 lb required mounting force. T=12 in-lb.



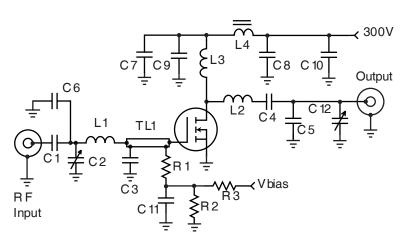




HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and mounting surface is beryllium oxide, BeO. Beryllium oxide dust is toxic when inhaled. Care must be taken during handling and mounting to avoid damage to this area These devices must never be thrown away

ARF1505 -- 27.12 MHz Test Circuit



C1, C7, C8, C11 .047mF 500V cerami disc C2, C12 Arco 465 75-380pF mica trimmer C3 2x 4700pF ATC 700B C4, C9-C10 8200pF 500V NPO ceramic C5 200pF ATC 100E C6 150pF ATC 700B L1 90nH 4t # 18 0.25"d .25"l L2 200nH - 3t # 8 1" dia 1"l L3 6 μ H - 22t # 24 enam 0.5"dia L4 500nH 2t on 850 μ .5" bead R1-R3 1K Ω 1/4W TL1 .112" x 1" (50 Ω) Stripline

